FDD6670A

March 2015



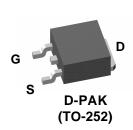
30V N-Channel PowerTrench^o MOSFET

General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $R_{DS(ON)}$, fast switching speed and extremely low $R_{DS(ON)}$ in a small package.

Applications

- DC/DC converter
- Motor Drives

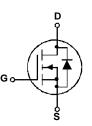


Features

• 66 A, 30 V
$$R_{DS(ON)} = 8 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$$

 $R_{DS(ON)} = 10 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$

- Low gate charge
- Fast Switching
- + High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$



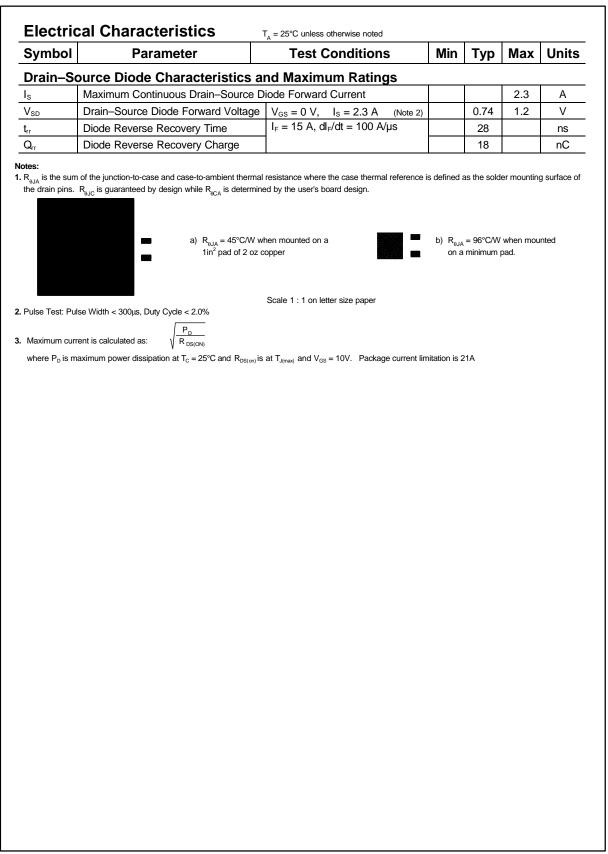
Absolute Maximum Ratings T_A=25°C unless otherwise noted

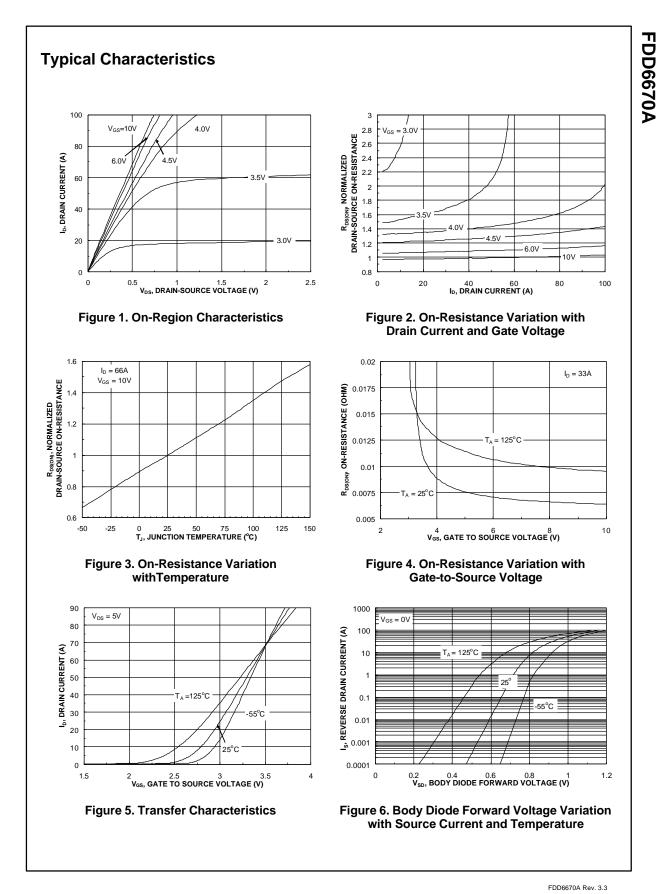
Symbol	Para	Parameter			Ratings		nits
V _{DSS}	Drain-Source Voltage	ce Voltage		30			V
V _{GSS}	Gate-Source Voltage	ce Voltage			±20		V
l _D	Continuous Drain Current	t @T _c =25°C	(Note 3)		66		А
		@T _A =25°C	(Note 1a)		15		
		Pulsed	(Note 1a)		100		
P _D	Power Dissipation	@T _c =25°C	(Note 3)		63		W
		@T _A =25°C	(Note 1a)		3.2		
		@T _A =25°C	(Note 1b)		1.3		
T _J , T _{S⊺G}	Operating and Storage Ju	and Storage Junction Temperature Range			-55 to +175		
Therma	I Characteristics						
R _{eJC}	Thermal Resistance, Jun	nal Resistance, Junction-to-Case (Note 1)			2.4		
R _{eja}	Thermal Resistance, Jun	esistance, Junction-to-Ambient (Note 1a)			40		
R _{eja}		(Note 1b)			96		
Packag	e Marking and Or	dering I	nformation)			
	Marking Devic		Package	Reel Size	Tape width	Quant	ity
FDD6670A FDD667		70A D	-PAK (TO-252)	13"	16mm	2500 u	nits

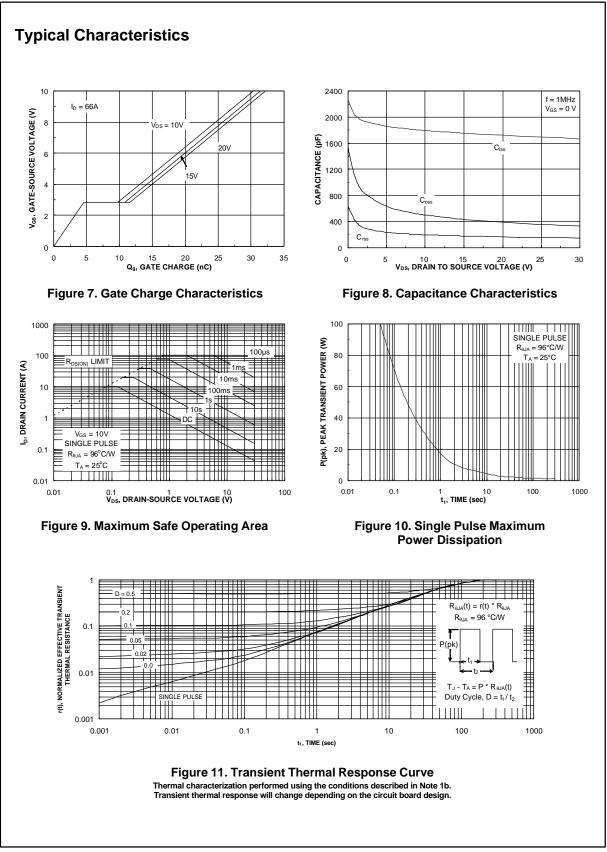
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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-Sc	burce Avalanche Ratings (Not	te 2)				
AS	Drain-Source Avalanche Energy	Single Pulse, $V_{DD} = 15 \text{ V}$, $I_D = 66 \text{ A}$			67	mJ
AS	Drain-Source Avalanche Current				66	Α
Off Char	racteristics					
3V _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 V$, $I_D = 250 \mu A$	30			V
Δ <mark>BV</mark> _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 µA,Referenced to 25°C		26		mV/°C
DSS	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 24 \text{ V}, \qquad V_{\text{GS}} = 0 \text{ V}$			1	μA
GSS	Gate–Body Leakage	$V_{\text{GS}} = \pm 20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$			±100	nA
On Char	acteristics (Note 2)					
/ _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, \qquad I_D = 250 \ \mu A$	1	1.8	3	V
$\Delta V_{GS(th)}$ ΔT_J	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}, \text{Referenced to } 25^{\circ}\text{C}$		-5		mV/°C
R _{DS(on)}	Static Drain–Source	$V_{GS} = 10 \text{ V}, I_{D} = 15 \text{ A}$		6.3	8	mΩ
	On Provintence	$V_{GS} = 4.5 \text{ V}, I_D = 13 \text{ A}$		7.9	10	
	On–Resistance			9.5	13	
D(on)	On-State Drain Current	$V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}, T_J = 125^{\circ}\text{C}$	50	9.5	13	A
			50	9.5 60	13	A S
FS	On–State Drain Current Forward Transconductance		50		13	
9⊧s Dynamic	On–State Drain Current Forward Transconductance Characteristics	$ \begin{array}{l} V_{GS} = 10 \ V, \ I_{D} = 15 \ A, T_{J} = 125^{\circ}C \\ V_{GS} = 10 \ V, \ V_{DS} = 5 \ V \\ V_{DS} = 10 \ V, \ I_{D} = 15 \ A \end{array} $	50		13	S
D _{FS} Dynamic C _{iss}	On–State Drain Current Forward Transconductance	$\begin{split} V_{GS} &= 10 \ V, \ I_D = 15 \ A, T_J = 125^\circ C \\ V_{GS} &= 10 \ V, \ V_{DS} = 5 \ V \\ V_{DS} &= 10 \ V, \ I_D = 15 \ A \\ \end{split}$	50	60	13	
C _{iss} C _{oss}	On–State Drain Current Forward Transconductance Characteristics Input Capacitance	$ \begin{array}{l} V_{GS} = 10 \ V, \ I_{D} = 15 \ A, T_{J} = 125^{\circ}C \\ V_{GS} = 10 \ V, \ V_{DS} = 5 \ V \\ V_{DS} = 10 \ V, \ I_{D} = 15 \ A \end{array} $	50	60 1755	13	S pF
Des Dynamic C _{iss} C _{oss} C _{rss}	On–State Drain Current Forward Transconductance C Characteristics Input Capacitance Output Capacitance	$\begin{split} V_{GS} &= 10 \ V, \ I_D = 15 \ A, T_J = 125^\circ C \\ V_{GS} &= 10 \ V, \ V_{DS} = 5 \ V \\ V_{DS} &= 10 \ V, \ I_D = 15 \ A \\ \end{split}$	50	60 1755 430	13	S pF pF
DFS Dynamic Diss Coss Crss Rg	On–State Drain Current Forward Transconductance C Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance	$\begin{split} V_{GS} &= 10 \ V, \ I_D &= 15 \ A, T_J = 125^\circ C \\ V_{GS} &= 10 \ V, \ V_{DS} &= 5 \ V \\ V_{DS} &= 10 \ V, \ I_D &= 15 \ A \\ \end{split}$	50	60 1755 430 180		S pF pF pF
DFS Dynamic Diss Coss Crss Crss Coss Crss Coss Crss Coss Co	On–State Drain Current Forward Transconductance Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance	$\begin{split} V_{GS} &= 10 \ V, \ I_D &= 15 \ A, T_J = 125^\circ C \\ V_{GS} &= 10 \ V, \ V_{DS} &= 5 \ V \\ V_{DS} &= 10 \ V, \ I_D &= 15 \ A \\ \end{split}$		60 1755 430 180	20	S pF pF pF
Ders Dynamic Cliss Clis	On–State Drain Current Forward Transconductance C Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance	$\begin{split} V_{GS} &= 10 \ V, \ I_D &= 15 \ A, T_J = 125^\circ C \\ V_{GS} &= 10 \ V, \ V_{DS} &= 5 \ V \\ V_{DS} &= 10 \ V, \ I_D &= 15 \ A \\ \end{split}$		60 1755 430 180 1.3		S pF pF Ω
Dynamic Dynamic Criss Criss Rg Switchir	On–State Drain Current Forward Transconductance Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance gCharacteristics (Note 2) Turn–On Delay Time	$\begin{array}{l} V_{GS} = 10 \ V, \ I_{D} = 15 \ A, T_{J} = 125^{\circ}C \\ V_{GS} = 10 \ V, \ V_{DS} = 5 \ V \\ V_{DS} = 10 \ V, \ I_{D} = 15 \ A \\ \end{array}$		60 1755 430 180 1.3 11	20	S pF pF Ω ns
DFS Dynamic Ciss Coss Crss Crss Crss Crss Crss Crss Cr	On-State Drain Current Forward Transconductance Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance gCharacteristics (Note 2) Turn-On Delay Time Turn-On Rise Time	$\begin{array}{l} V_{GS} = 10 \ V, \ I_{D} = 15 \ A, T_{J} = 125^{\circ}C \\ \hline V_{GS} = 10 \ V, \ V_{DS} = 5 \ V \\ \hline V_{DS} = 10 \ V, \ I_{D} = 15 \ A \\ \hline \end{array}$		60 1755 430 180 1.3 11 12	20 21	S pF pF Ω ns ns
DFS Dynamic Ciss Coss Crss R G Switchir a(on) r a(off)	On–State Drain Current Forward Transconductance Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Definition Delay Time Turn–On Rise Time Turn–On Rise Time	$\begin{array}{l} V_{GS} = 10 \ V, \ I_{D} = 15 \ A, T_{J} = 125^{\circ}C \\ \hline V_{GS} = 10 \ V, \ V_{DS} = 5 \ V \\ \hline V_{DS} = 10 \ V, \ I_{D} = 15 \ A \\ \hline \end{array}$		60 1755 430 180 1.3 11 12 29	20 21 47	S pF pF Ω ns ns ns
DFS Dynamic C _{iss} C _{oss} C _{rss} R _G	On–State Drain Current Forward Transconductance Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics (Note 2) Turn–On Delay Time Turn–On Rise Time Turn–Off Delay Time Turn–Off Fall Time	$\begin{array}{l} V_{GS} = 10 \ V, \ I_{D} = 15 \ A, T_{J} = 125^{\circ}C \\ \hline V_{GS} = 10 \ V, \ V_{DS} = 5 \ V \\ \hline V_{DS} = 10 \ V, \ I_{D} = 15 \ A \\ \hline \end{array}$		60 1755 430 180 1.3 11 12 29 19	20 21 47 34	S pF pF Ω ns ns ns

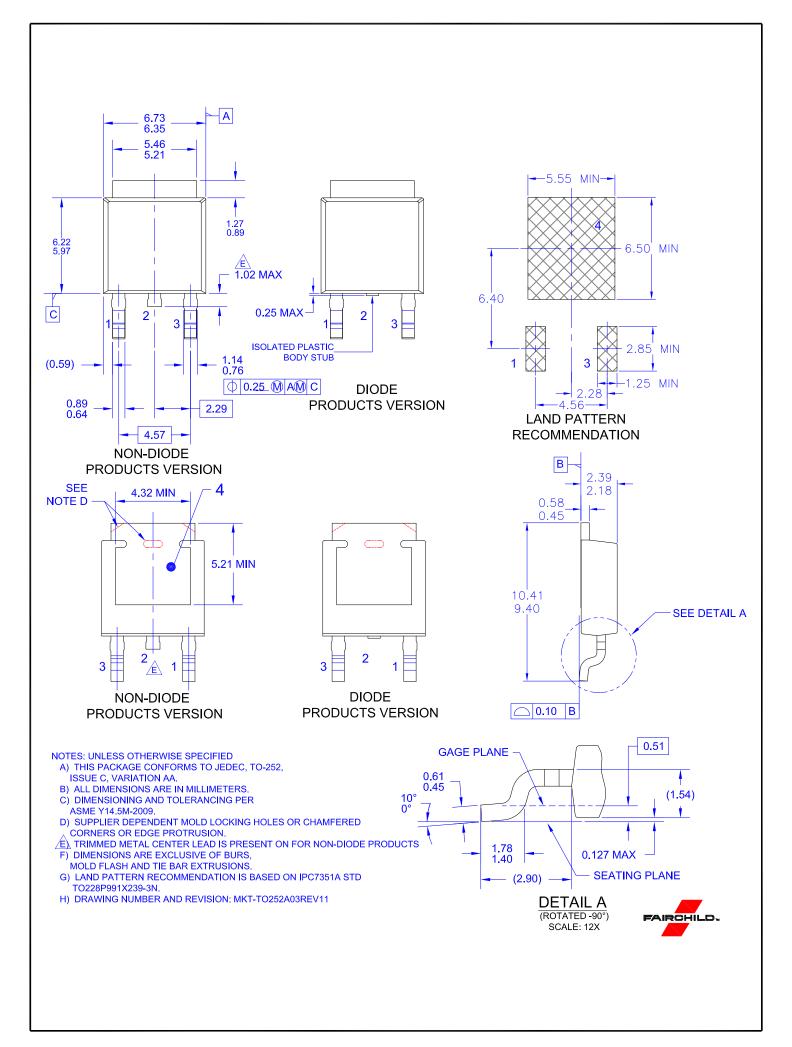
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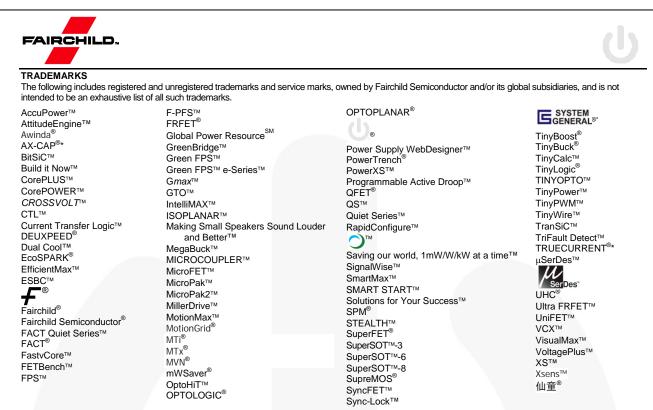






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